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Form PTO 1449		U.S. DEPARTMENT		249594US3		SERIAL NO.	
(Modified)		PATENT AND TRAD	EMARK OFFICE			10/812,971	
				APPLICANT			
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Toshiaki TAKAHASHI, et al.			
				FILING DATE		GROUP	
				March 31, 2004		2652	
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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE , IF APPROPRIATE
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	DOCUMENT DATE COUNTRY					TRANSLATION	
		NUMBER	DATE	COUNTRY		YES	МО
Dr.	AO	2923207	04/30/1999	JAPAN (with English Abstract)			×
0	AP	2002-96933	04/02/2002	JAPAN (with English Abstract)			X
m-	AQ	6-1349	01/11/1994	JAPAN (with English Abstract)			×
	AR						
	AS						
	AT						
	AU						
	AV		<u> </u>				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ	Additional References sheet(s) att					rences sheet(s) attached
Examine					Date Considered 07/07/05		
*Examiner: Initial.if-reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							